

US008009356B1

(12) United States Patent

Shaner et al.

(10) Patent No.: U

US 8,009,356 B1

(45) **Date of Patent:**

Aug. 30, 2011

(54) TUNABLE SURFACE PLASMON DEVICES

(75) Inventors: **Eric A. Shaner**, Rio Rancho, NM (US); **Daniel Wasserman**, Lowell, MA (US)

(73) Assignee: Sandia Corporation, Albuquerque, NM

(US)

(*) Notice: Subject to any disclaimer, the term of this

patent is extended or adjusted under 35

U.S.C. 154(b) by 611 days.

(21) Appl. No.: 12/137,882

(22) Filed: Jun. 12, 2008

Related U.S. Application Data

- (60) Provisional application No. 61/036,292, filed on Mar. 13, 2008.
- (51) **Int. Cl. G02B 5/18** (2006.01)
- (52) **U.S. Cl.** **359/573**; 359/569; 359/288

(56) References Cited

U.S. PATENT DOCUMENTS

5,973,316 A	10/1999	Ebbesen et al.
6,040,936 A	3/2000	Kim et al.
6,982,819 B2*	1/2006	Sawin et al 359/245
7,057,786 B2*	6/2006	Sawin et al 359/245
7,110,154 B2	9/2006	Ballato et al.
7,206,114 B2	4/2007	Ballato et al.
7,701,629 B2*		Wang et al 359/248
7,880,251 B2*	2/2011	Wang et al 257/431

OTHER PUBLICATIONS

- E. A. Shaner et al, "Electrically tunable extraordinary optical transmission gratings", Applied Physics Letters, vol. 91, (2007) pp. 181110-1 through 181110-3.
- D. Wasserman et al, "Midinfrared doping-tunable extraordinary transmission from sub-wavelength Gratings", Applied Physics Letters, vol. 90, (2007) pp. 191102-1 through 191102-3.
- C. Janke, et al, "All-Optical switching of the transmission of electromagnetic radiation through subwavelength apertures", Optical Society of America, vol. 30, No. 18, 2005, pp. 2357-2359.
- * cited by examiner

Primary Examiner — Arnel C Lavarias (74) Attorney, Agent, or Firm — Carol I Ashby

(57) ABSTRACT

A tunable extraordinary optical transmission (EOT) device wherein the tunability derives from controlled variation of the dielectric constant of a semiconducting material (semiconductor) in evanescent-field contact with a metallic array of sub-wavelength apertures. The surface plasmon resonance wavelength can be changed by changing the dielectric constant of the dielectric material. In embodiments of this invention, the dielectric material is a semiconducting material. The dielectric constant of the semiconducting material in the metal/semiconductor interfacial region is controllably adjusted by adjusting one or more of the semiconductor plasma frequency, the concentration and effective mass of free carriers, and the background high-frequency dielectric constant in the interfacial region. Thermal heating and/or voltage-gated carrier-concentration changes may be used to variably adjust the value of the semiconductor dielectric constant.

17 Claims, 17 Drawing Sheets



